

Notice of References Cited	Application/Control No. 10/661,983		Applicant(s)/Patent Under Reexamination WILDER ET AL.	
	Examiner Christian E. Rendón		Art Unit 3714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,517,433	02-2003	Loose et al.	463/20
*	B	US-5,655,961	08-1997	Acres et al.	463/27
*	C	US-2001/0048507 a1	12-2001	Thomas et al.	353/10
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Cees van Berkel and John A. Clarke, "Characterisation and Optimisation of 3D-LCD Module Design", Feb 11-14 1997, SPIE International Conference on Electronic Imaging
	V	Cees van Berkel, A R Franklin and J R Mansell, "Design and Applications of Multiview 3D-LCD", Oct 1996, 1996 EuroDisplay Conference, pp. 109-112
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.